

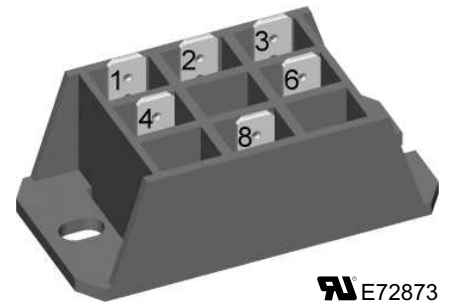

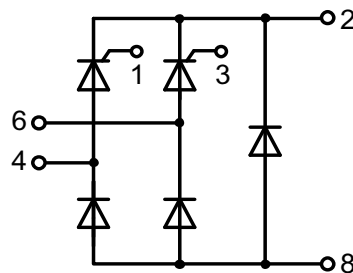
# Half Controlled Single Phase Rectifier Bridge with Freewheeling Diode

$$I_{dAVM} = 21 \text{ A}$$

$$V_{RRM} = 800-1600 \text{ V}$$

## Part numbers

$V_{RSM}$	$V_{RRM}$	Type
$V_{DSM}$	$V_{DRM}$	
V	V	
900	800	VHF 15-08io5
1300	1200	VHF 15-12io5
1700	1600	VHF 15-16io5


 E72873


### Features / Advantages:

- Planar passivated chips
- Space and weight savings
- Improved temperature & power cycling

### Applications:

- Supply for DC power equipment
- DC motor control

### Package: FO-F

- Isolation Voltage: 3600 V~
- DCB ceramic base plate
- 1/4" fast-on terminals
- Easy to mount with two screws
- RoHS compliant

### Disclaimer Notice

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Diodes				Ratings			
Symbol	Definitions	Conditions	min.	typ.	max.	Unit	
$I_{dAV}$	average DC output current	module			15	A	
$I_{dAVM}$	max. average DC output current	for resistive load			21	A	
$I_{FRMS}, I_{TRMS}$	RMS forward current	per leg			15	A	
$I_{FSM}, I_{TSM}$	max. surge forward current	$t = 10\text{ ms}$ (50 Hz), sine $t = 8.3\text{ ms}$ (60 Hz), sine; $V_R = 0\text{ V}$	$T_{VJ} = 45^\circ\text{C}$		190 210	A A	
		$t = 10\text{ ms}$ (50 Hz), sine $t = 8.3\text{ ms}$ (60 Hz), sine; $V_R = 0\text{ V}$	$T_{VJ} = 125^\circ\text{C}$		170 190	A A	
$I^2t$	$I^2t$ value for fusing	$t = 10\text{ ms}$ (50 Hz), sine $t = 8.3\text{ ms}$ (60 Hz), sine; $V_R = 0\text{ V}$	$T_{VJ} = 45^\circ\text{C}$		160 180	A <sup>2</sup> s A <sup>2</sup> s	
		$t = 10\text{ ms}$ (50 Hz), sine $t = 8.3\text{ ms}$ (60 Hz), sine; $V_R = 0\text{ V}$	$T_{VJ} = 125^\circ\text{C}$		140 145	A <sup>2</sup> s A <sup>2</sup> s	
$(di/dt)_{cr}$	critical rate of rise of current	$f = 50\text{ Hz}$ , $t_p = 200\text{ }\mu\text{s}$ , $V_D = 2/3 V_{DRM}$ , $T_{VJ} = 125^\circ\text{C}$ $I_G = 0.3\text{ A}$ , $di_G/dt = 0.3\text{ A}/\mu\text{s}$					
					150 500	A/ $\mu\text{s}$ A/ $\mu\text{s}$	
$(dv/dt)_{cr}$	critical rate of rise of voltage	$V_D = 2/3 V_{DRM}$ $R_{GK} = \infty$ ; method 1 (linear voltage rise)	$T_{VJ} = 125^\circ\text{C}$		1000	V/ $\mu\text{s}$	
$V_{RGM}$	max. reverse gate voltage				10	V	
$P_{GM}$	max. gate power dissipation	$I_T = I_{TAVM}$	$T_{VJ} = 125^\circ\text{C}$		10 5 1	W W W	
		$t_p = 30\text{ }\mu\text{s}$ $t_p = 500\text{ }\mu\text{s}$ $t_p = 10\text{ ms}$					
$P_{GAVM}$	max. average gate power dissipation				0.5	W	

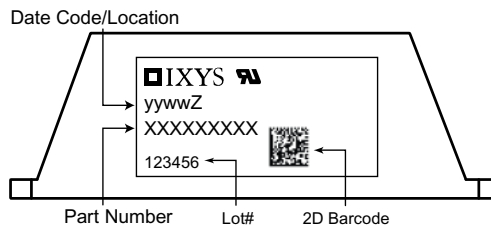
Thyristors				Ratings			
Symbol	Definitions	Conditions	min.	typ.	max.	Unit	
$I_R, I_D$	reverse, drain current	$V_R = V_{RRM}$ ; $V_D = V_{DRM}$	$T_{VJ} = 25^\circ\text{C}$ $T_{VJ} = 125^\circ\text{C}$		0.3 5	mA mA	
$V_T, V_F$	forward voltage	$I_T, I_F = 45\text{ A}$	$T_{VJ} = 25^\circ\text{C}$		2.8	V	
$V_{TO}$		For power-loss calculations only	$T_{VJ} = 125^\circ\text{C}$	1.0		V	
$r_T$				40		m $\Omega$	
$V_{GT}$	gate trigger voltage	$V_D = 6\text{ V}$	$T_{VJ} = 25^\circ\text{C}$ $T_{VJ} = -40^\circ\text{C}$		1.0 1.2	V V	
$I_{GT}$	gate trigger current	$V_D = 6\text{ V}$	$T_{VJ} = 25^\circ\text{C}$ $T_{VJ} = -40^\circ\text{C}$ $T_{VJ} = 125^\circ\text{C}$		65 80 50	mA mA mA	
$V_{GD}$	gate non-trigger voltage	$V_D = 2/3 V_{DRM}$	$T_{VJ} = 125^\circ\text{C}$		0.2	V	
$I_{GD}$	non-trigger gate current				5	mA	
$I_L$	latching current	$I_G = 0.3\text{ A}$ , $t_G = 30\text{ }\mu\text{s}$ $di_G/dt = 0.3\text{ A}/\mu\text{s}$	$T_{VJ} = 25^\circ\text{C}$ $T_{VJ} = -40^\circ\text{C}$ $T_{VJ} = 125^\circ\text{C}$		150 200 100	mA mA mA	
$I_H$	holding current	$V_D = 6\text{ V}$ , $R_{GK} = \infty$	$T_{VJ} = 25^\circ\text{C}$		100	ns	
$t_{gd}$	gate controlled delay time	$V_D = 1/2 V_{DRM}$ $I_G = 0.3\text{ A}$ , $di_G/dt = 0.3\text{ A}/\mu\text{s}$	$T_{VJ} = 25^\circ\text{C}$	150		$\mu\text{s}$	
$t_{ri}$	turn-off time	$I_T = 15\text{ A}$ , $t_p = 300\text{ }\mu\text{s}$ , $V_R = 100\text{ V}$ ; $T_{VJ} = 125^\circ\text{C}$		150		$\mu\text{s}$	
$Q_r$	reverse recovery charge	$di/dt = -10\text{ A}/\mu\text{s}$ , $dv/dt = 20\text{ V}/\mu\text{s}$ , $V_D = 2/3 V_{DRM}$		75		$\mu\text{C}$	
$R_{thJC}$	thermal resistance junction to case	per thyristor (diode); DC current per module			2.4 0.6	K/W K/W	
$R_{thJH}$	thermal resistance junction to heatsink	per thyristor (diode); DC current per module		3.0 0.75		K/W K/W	

Data according to IEC 60747 and refer to a single thyristor/diode unless otherwise stated.

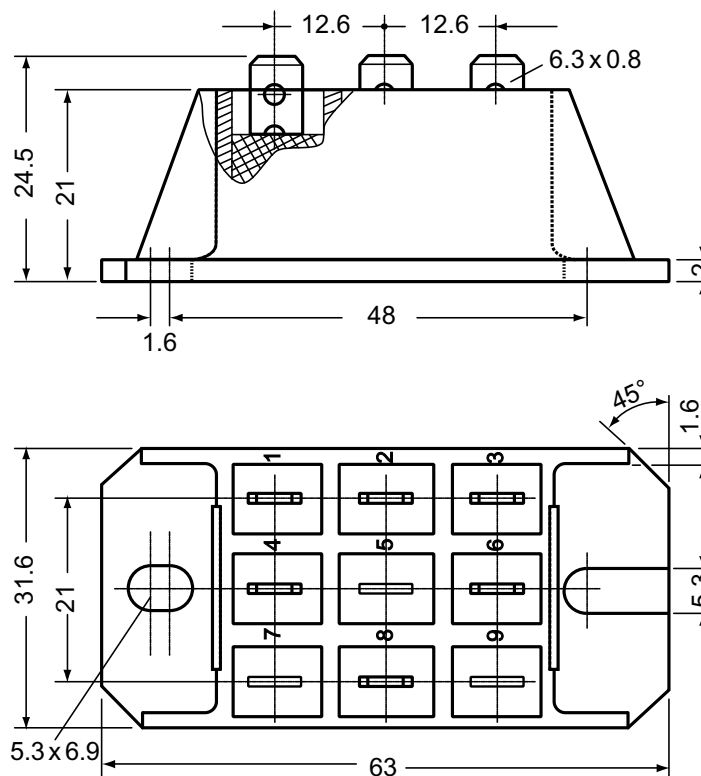
IXYS reserves the right to change limits, test conditions and dimensions.

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Package FO-F				Ratings		
Symbol	Definitions	Conditions	min.	typ.	max.	Unit
$I_{RMS}$	RMS current	per terminal			100	A
$T_{VJ}$	virtual junction temperature		-40		125	°C
$T_{op}$	operation temperature		-40		100	°C
$T_{stg}$	storage temperature		-40		125	°C
<b>Weight</b>				45		g
$M_D$	mounting torque		2		2.5	Nm
$d_{Spp/App}$	creepage distance on surface / striking distance through air	terminal to terminal	18.0	6.0		mm
$d_{Spb/Apb}$		terminal to backside	26.0	20.0		mm
$V_{ISOL}$	isolation voltage	t = 1 second	50/60 Hz, RMS, $I_{ISOL} \leq 1$ mA		3600	V
		t = 1 minute			3000	V



Dimensions in mm (1 mm = 0.0394")



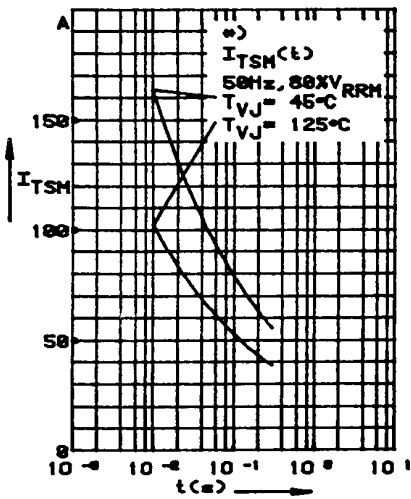


Fig. 1 Surge overload current per chip  
 $I_{FSM}$ : Crest value,  $t$ : duration

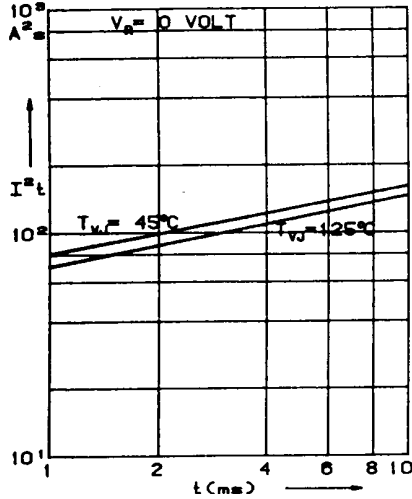


Fig. 2  $I^2t$  versus time (1-10 ms) per chip

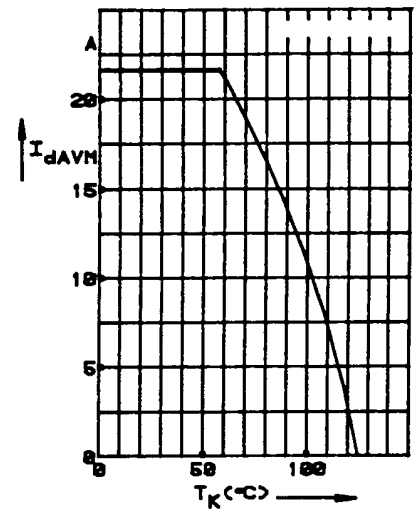


Fig. 3 Max. forward current at heatsink temperature

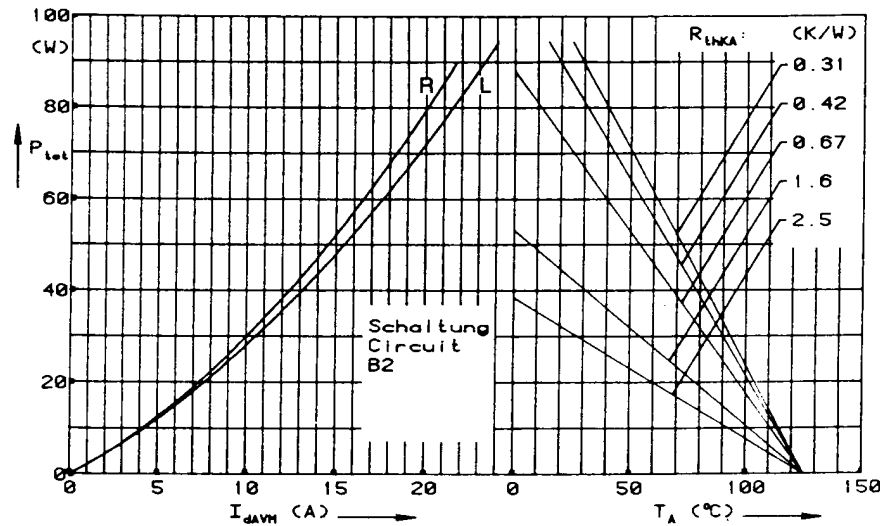


Fig. 4 Power dissipation versus direct output current and ambient temperature

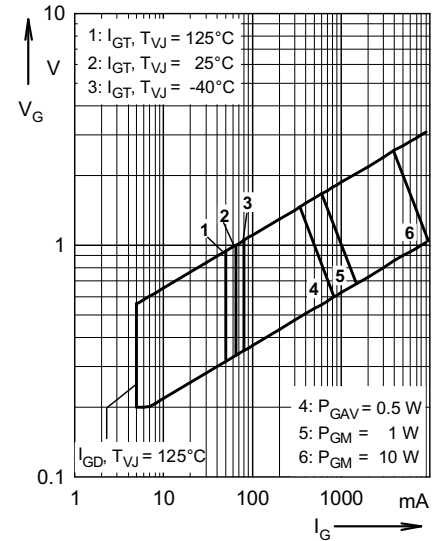


Fig. 5 Gate trigger range

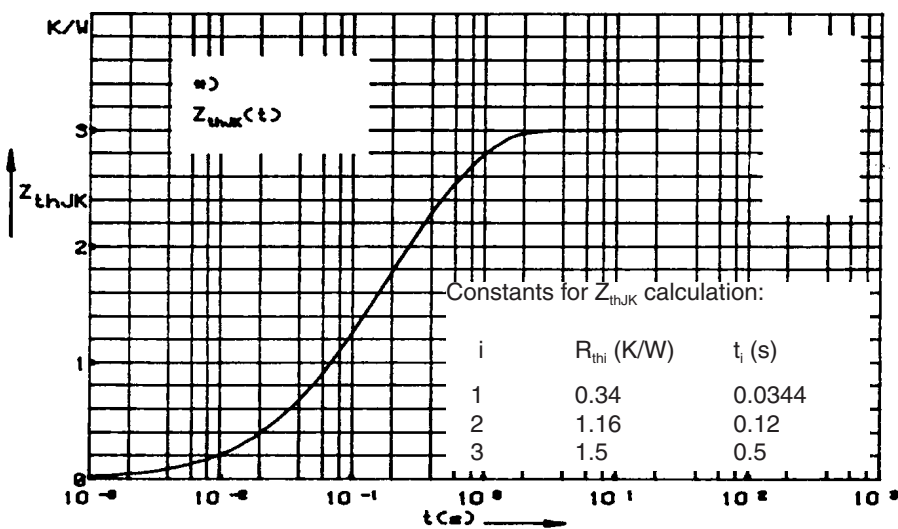


Fig. 6 Transient thermal impedance junction to heatsink per chip  
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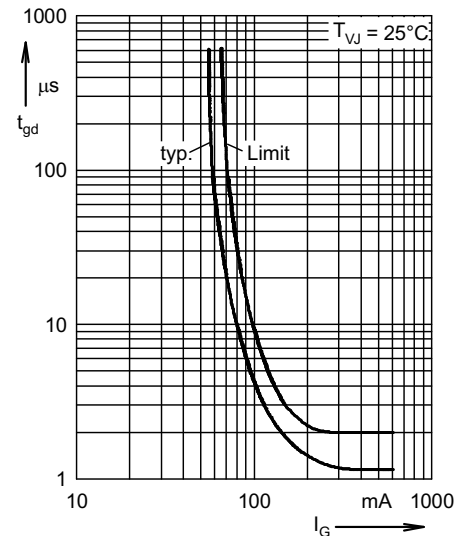


Fig. 7 Gate controlled delay time